

Fujitsu Lead-free Package

Semiconductor Group
LSI Packaging Division

History of Fujitsu Lead-free Package Development Activities

- Lead-free Package Development to Commence [April 1998 Completed]**
- Customers Application Trend Research [Sept 1998 Completed]**
- Lead-free BGA Mass Production [April 2000 Partially started]**
- Lead-free QFP Mass Production [Oct 2000 Partially started]**
- Target For All LSI Products ultimately lead-free [Dec 2002]**

Lead-free Package Definition

Fujitsu Lead Free Package Specification

Ecologically friendly package with lead being eliminated from its terminal-use material and improved heat resistivity.

Heat Resistivity

260°C (250°C) x 2 Reflows

Terminal Material

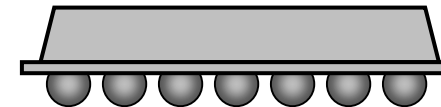
BGA = Sn-37Pb (Non Lead-free) → Sn-3.0Ag-0.5Cu (Lead-free)



When compared with non lead-free:

1. A bit dull in color; less lustrous
2. Similar wettability
3. Similar on-board reliability
4. Similar solder combination mounting

BGA



Solder ball

Lead-free Package Definition

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Heat Resistivity

260 °C (250°C)x 2 Reflows

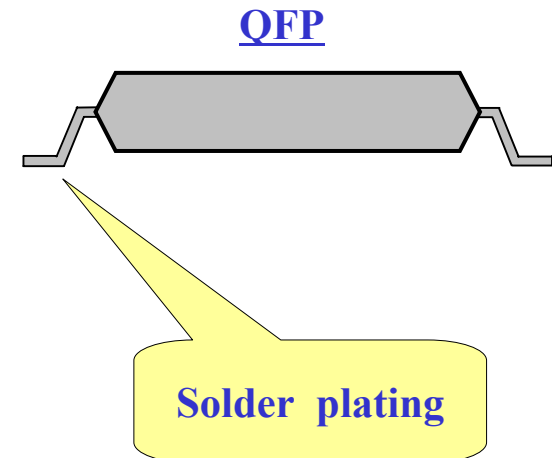
Terminal Material

QFP = Sn-10Pb (Non lead-free) → Sn-2.0Bi (Lead-free)



When compared with non lead-free:

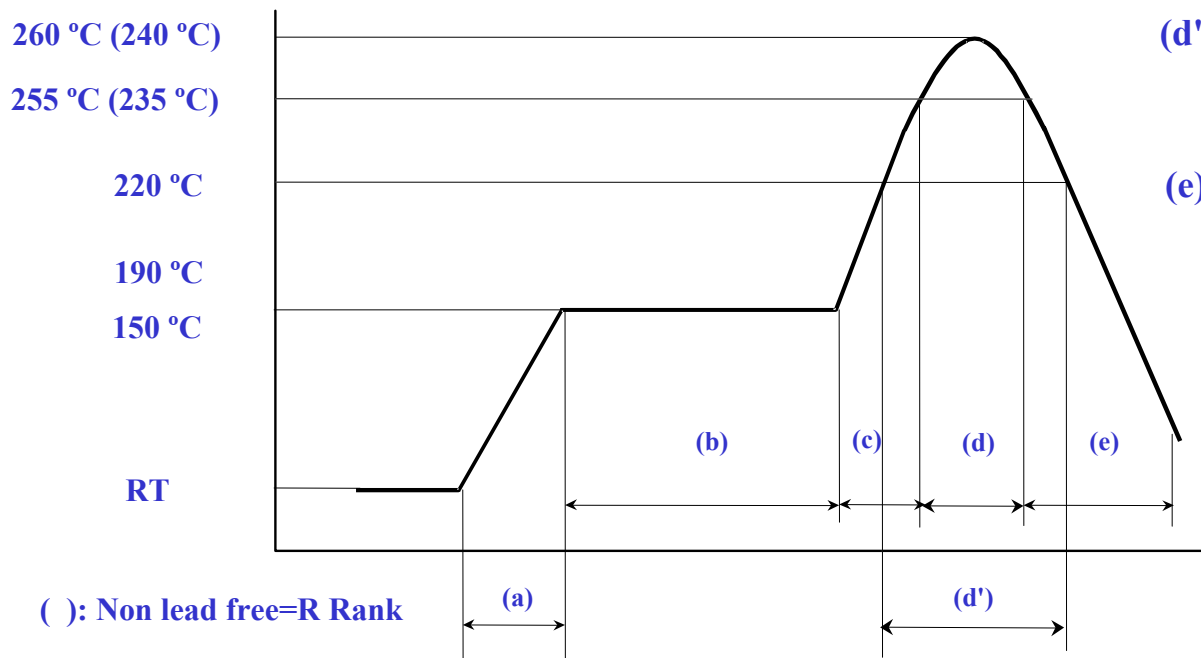
1. A bit dull in color; less lustrous
2. Similar wettability
3. Similar on-board reliability
4. Similar solder combination mounting



Lead-free Temperature Profile

* Package Surface Temp.

H Rank

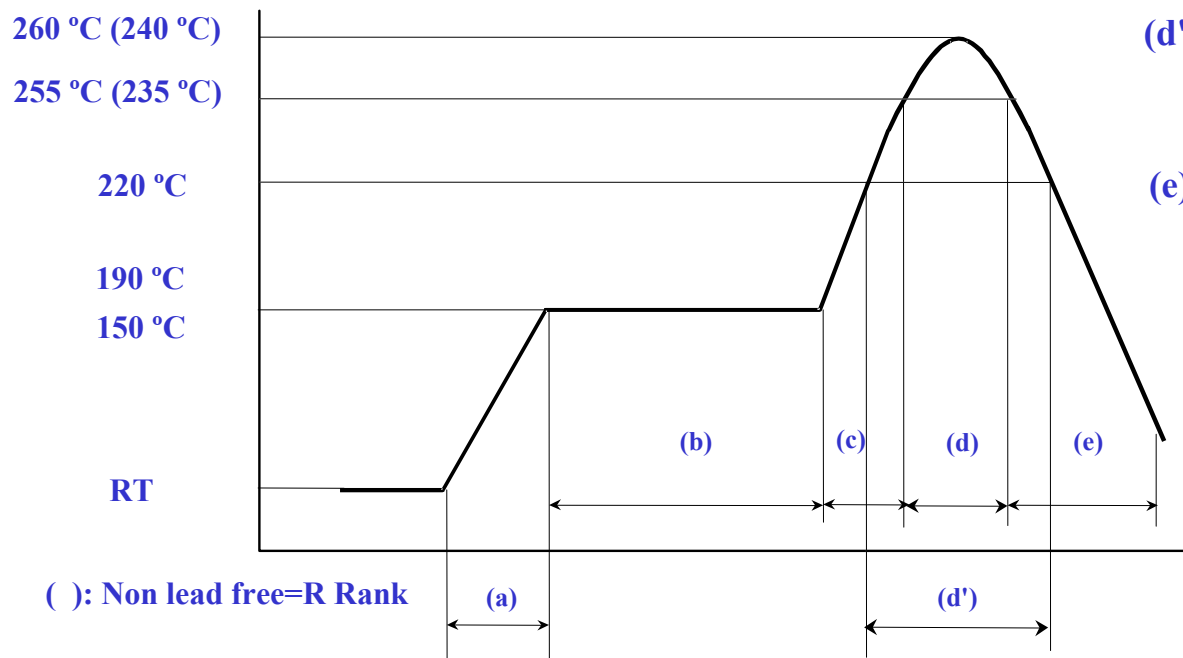


- (a) Temp. inc. gradient : Av. 1~4°C/sec
- (b) Preliminary heating : 150~190°C, 120~180sec
- (c) Temp. inc. gradient : Av. 1~4°C/sec
- (d) Peak Temp : 260°C max.
255°C up 10 sec max.
- (d') Actual heating : 230°C up 40 sec max.
225°C up 60sec max.
220°C up 80sec max.
- (e) Cooling : Natural Cooling or
Forced Cooling

Lead-free Temperature Profile

* Package Surface Temp.

M Rank

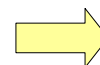


- (a) Temp. inc. gradient : Av. 1~4°C/sec
- (b) Preliminary heating : 150~190°C, 120~180sec
- (c) Temp. inc. gradient : Av. 1~4°C/sec
- (d) Peak Temp : 250°C max.
245°C up 10 sec max.
- (d') Actual heating : 230°C up 40 sec max.
225°C up 60sec max.
220°C up 80sec max.
- (e) Cooling : Natural Cooling or Forced Cooling

Discrimination of Lead-free Products

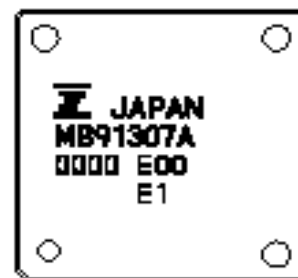
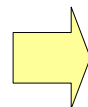
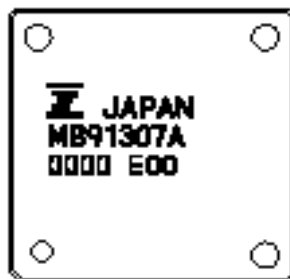
- Part Number : Add E1 at the end

(Ex) MBLM29LV160TE90PBT-JJ

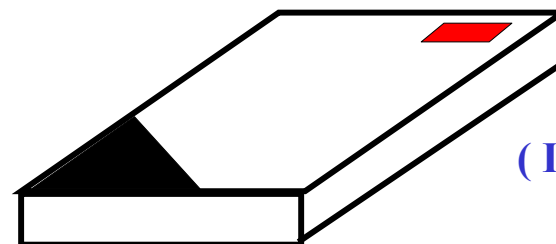
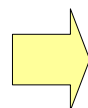


MB29LV160TE90PBT-JJE1

- Marking : Add "E1" at the end



- Attach lead-free sticker to mark on aluminum-laminated bag and on inner box



(Inner Box)

Pb-Free Plan & Status

Package		CY2001	CY2002	CY2003
QFP/SOP	QFP	}	→ Mass-Production	}
	LQFP			
	TQFP			
	SSOP			
	TSOP			
BGA	PBGA		→ Mass-Production	} 2002.Dec. 100%
	FBGA		→ Mass-Production	
	TAB-BGA	→ Eval.	→ MP April ~	
	EBGA	→ Eval.	→ MP June ~	
	FCBGA	→ Eval.	→ MP June ~	
LGA	FLGA		→ Mass-Production	
BCC	BCC		→ Mass-Production	
WLP	Super CSP		→ Eval. → MP April ~	

Thermal Performance Grouping

**Grouping
(Non Lead-free)**

Group	BGA	QFP / SOP
A:260Cmax	SCSP Small-FBGA PBGA BCC	SOP TSOP TQFP
B:250Cmax	Large-FBGA SMCP	QFP LQFP
C:240Cmax	FLGA EBGA TBGA SMCP*	HQFP

Method

Item	BGA	QFP / SOP
Package Material	<ul style="list-style-type: none"> • Substrate Material • Die Paste Material • Encapsulation Resin 	<ul style="list-style-type: none"> • Die Paste Material • Encapsulation Resin
Package Structure	————	<ul style="list-style-type: none"> • Die stage Structure • Die stage Dimension

**Result
(Lead-free)**

Group	Non Lead-free			Lead-free		
	240C	250C	260C	240C	250C	260C
A:260Cmax	○	○	○	○	○	○
B:250Cmax	○	○	×	○	○	○
C:240Cmax	○	×	×	○	○	×

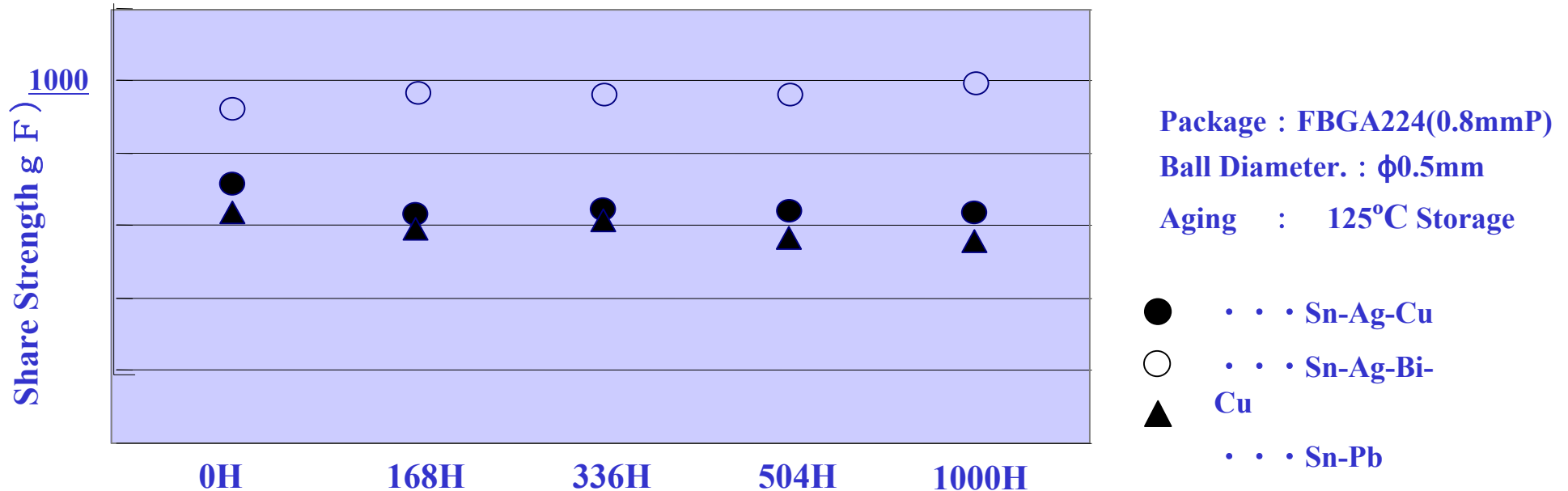
Evaluation Summary (Sn-Bi)

	Heat Resistivity	Moisture Resistivity	Wettability
TSOP	260°C	A	A
SOP	260 ~ 280°C	A	A
TQFP	260°C	A	A
LQFP	250 ~ 260°C	A	A
QFP	250 ~ 260°C	A	A

BGA Ball Evaluation

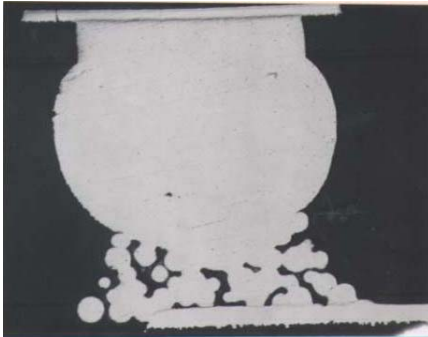
Composition	Advantage	Disadvantage
Sn-Ag-Cu	Better Mounting Reliability than Sn-Pb/Sn-Pb	High Melting Point (220°C)
Sn-Ag-Bi-Cu	Lower Melting point than Sn-Ag-Cu	Lower Mounting Reliability by Bi content increase

Ball share Strength

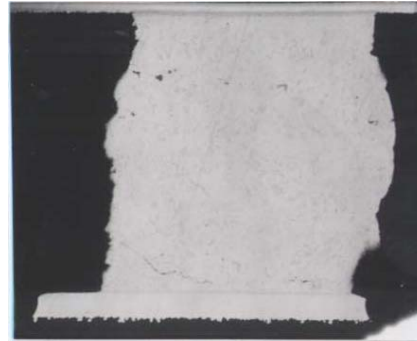


Reflow Peak Temperature & Solder-joint

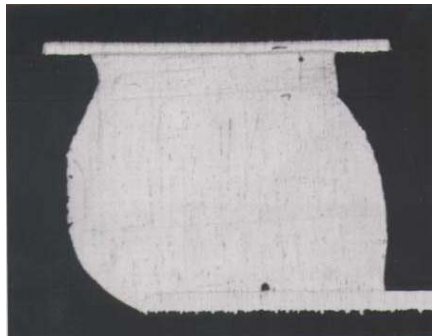
* Jointable at 230°C



Peak Temperature
210°C typical



Peak Temperature
220°C typical



Peak Temperature
230°C typical



Peak Temperature
220°C typical

【Condition】

Ball material : Sn-3.5Ag-0.75Cu

Paste material : Sn-3.5Ag-0.75Cu

Reflow method : IR/Hot air

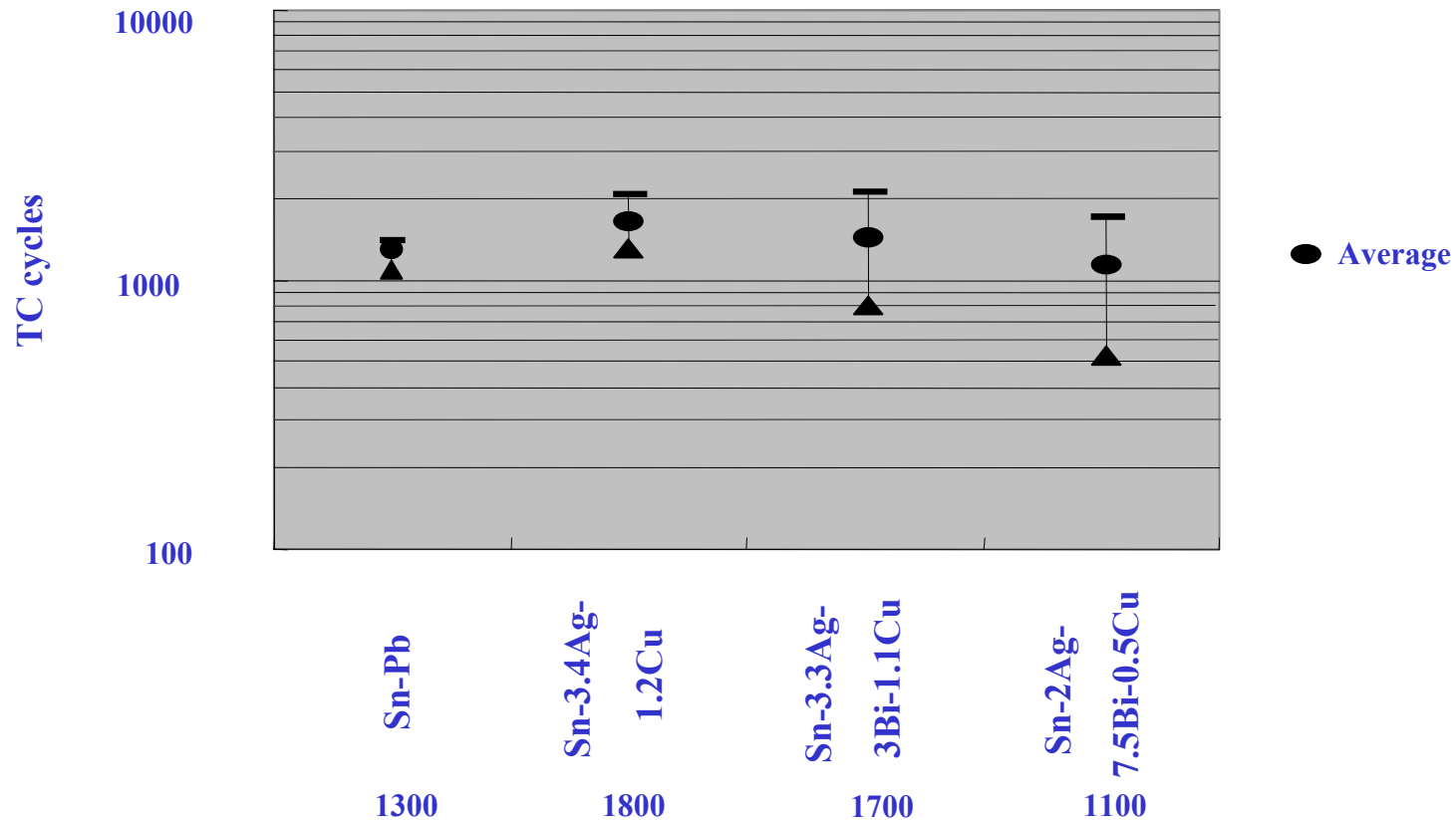
Peak Temp : Joint Temp

On-Board Thermal Cycle

Sample : FBGA224(0,8mm pitch) Ball Diameter: ϕ 0,5mm

Substrate : 110mmX110mmX0.8mm t ,4-layers , Land Diameter: ϕ 0.3mm(NSMD)

Test Condition : -25°C (9min)~RT(1min)~125°C (9min)



Plating Material Evaluation

Note : Each Metallic Additives Ratio is 2~3%

Plating Material	Whisker	Wettability	Joint strength	Cost
		⊙	⊙	
Sn - Bi	○	○	⊙	○
Sn - Ag	△	△	⊙	△ *
Sn - Cu	△ *	△	⊙	○
Sn - Zn	△ *	○ *	○	△
Sn	△	△	⊙	⊙
Test Condition	50°C Aging	Meniscograph (Zero-Crosstime)	Peel Strength (Thermal Cycle)	Material Cost
Legend	⊙ : Reference ○ : Not Observed △ : Observed	⊙ : Reference ○ : Moderate Long △ : Long	⊙ : Reference ○ : Weak	⊙ : Reference ○ : Moderate Expensive △ : Expensive

Zero-Cross Time

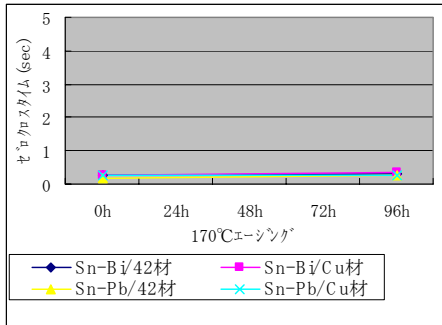
Sample Size : 3.30xo.46xo.25t Dipping Speed :10mm/sec Dipping Depth : 1mm

Test Condition-1

Solder : Sn-Ag-Bi-Cu

Solder Temperature : 230°C

Flux : RA type

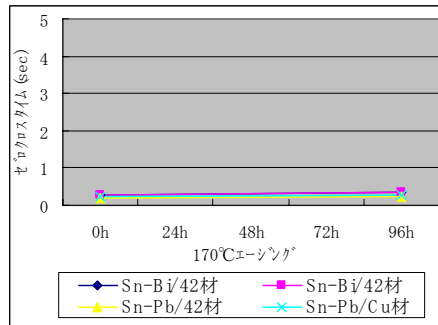


Test Condition-2

Solder : Sn-Ag--Cu

Solder Temperature : 230°C

Flux : RA type

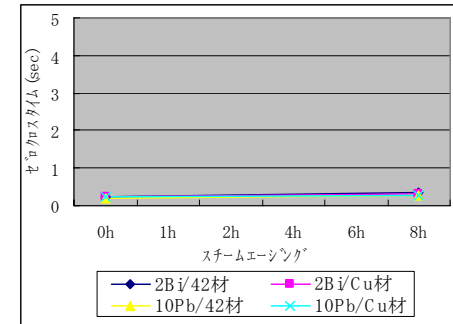
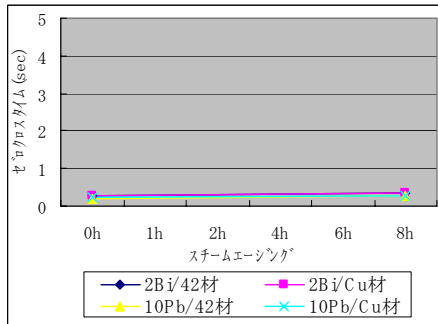
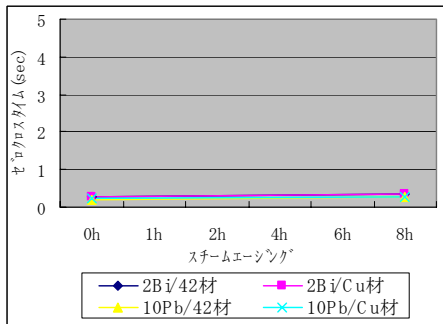
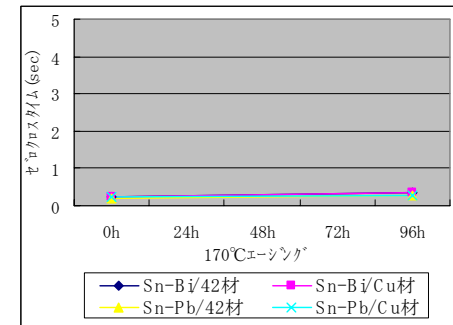


Test Condition-3

Solder : Sn-Pb(Reference)

Solder Temperature : 220°C

Flux : RA type



Crosssection of Connection(Sn-Bi Plating)

Package : QFP208(0.5mm pitch)



A) Paste : Eutectic Solder Lead Frame : 42-Alloy Reflow Temperature :230°C

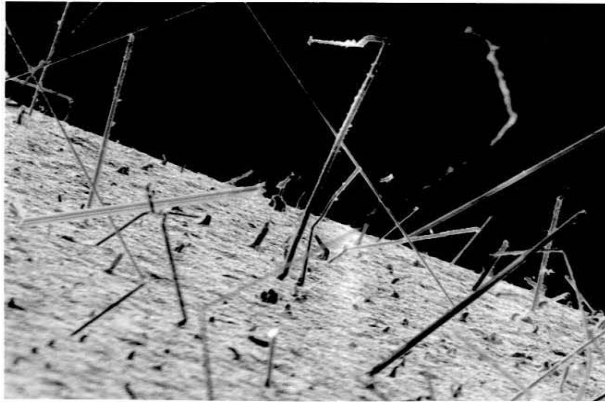


B) Paste : Sn-Ag-Cu Lead Frame : 42-Alloy Reflow Temperature :240°C

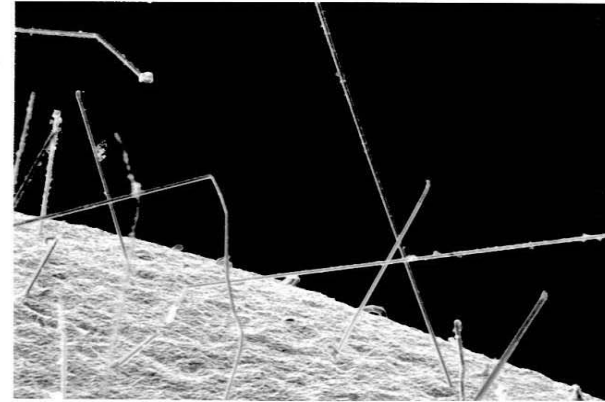


Example of Lead-free Whisker

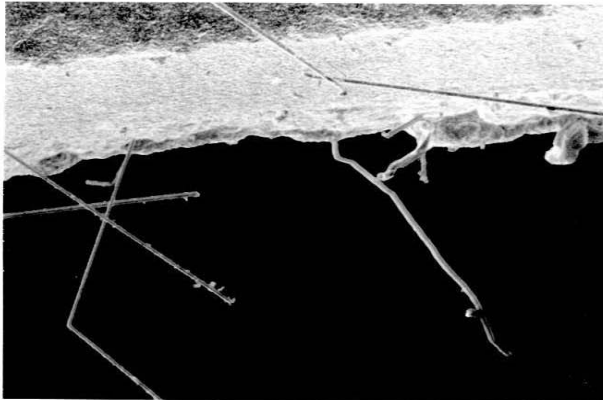
Sample A : Sn-Cu (42Alloy)



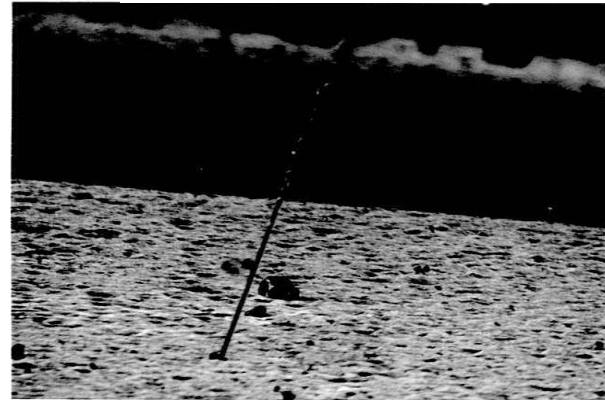
Sample A : Sn-Cu (42Alloy)



Sample A: Sn-Cu (42Alloy)

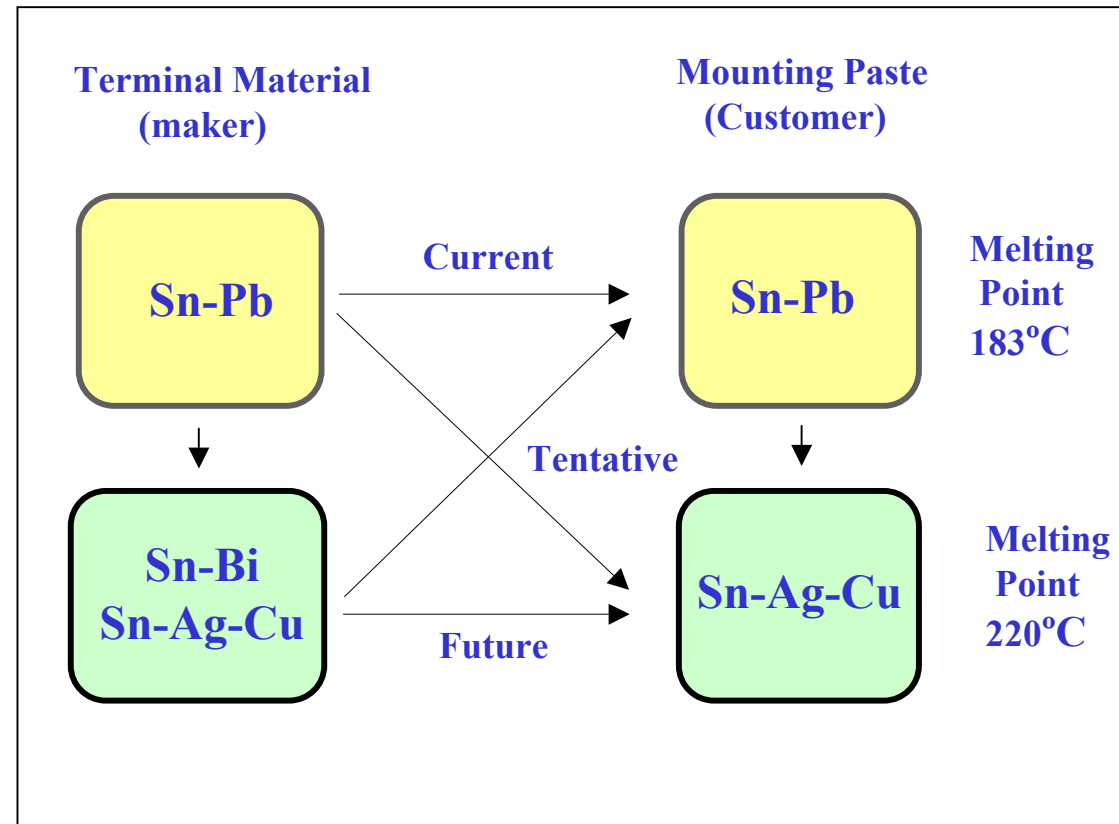
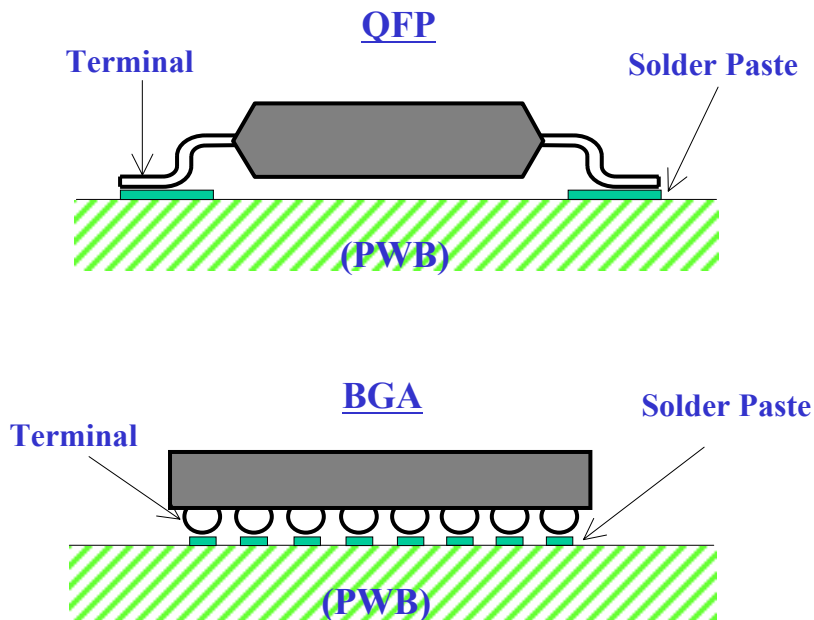


Sample B: Sn-Ag (42Alloy)



Target of Mountability

- ★ Improvement of Package Heat Resistivity
- ★ Quality Assurance of Soldering Mountability



Ball Adhesive Strength

Package : FBGA224(16mmx16mm)

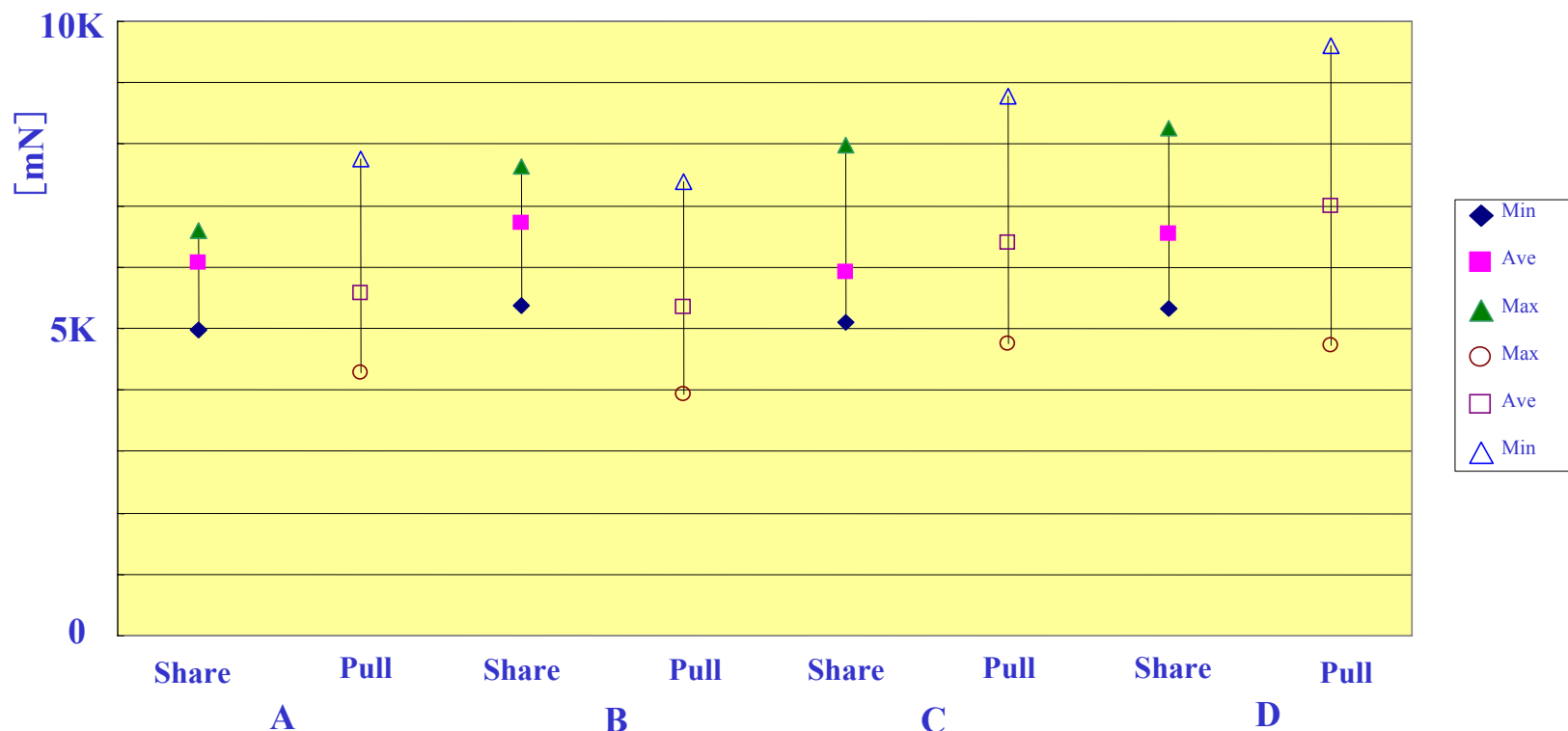
Solder Ball Diameter : $\phi 0.45\text{mm}$

A : Eutectic Ball + Eutectic Paste

B : Sn-Ag-Cu Ball + Eutectic Paste

C : Sn-Ag-Cu Ball + Sn-Ag-Cu Paste

D : Sn-Ag-Cu Ball + Sn-Ag-Bi-Cu Paste



(Damage Mode)

Share : A~D=Normal(Solder Part sliced)

Pull : A=Normal(Solder torn) B,C,D=Interface Delamination

Solder Combination Evaluation(Thermal Cycle)

Board : FR-4,110mm x 110mm x 0.8mmt

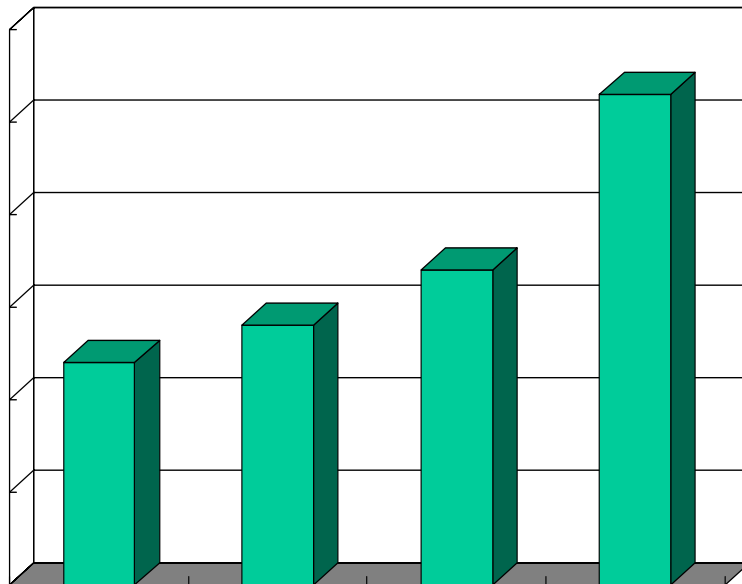
Package : FBGA (6 x 8 mm)/ FBGA (16 x 16 mm)

TC condition : -25°C ~ RT ~ 125°C

Non fail cycles

FBGA (6 x 8mm)

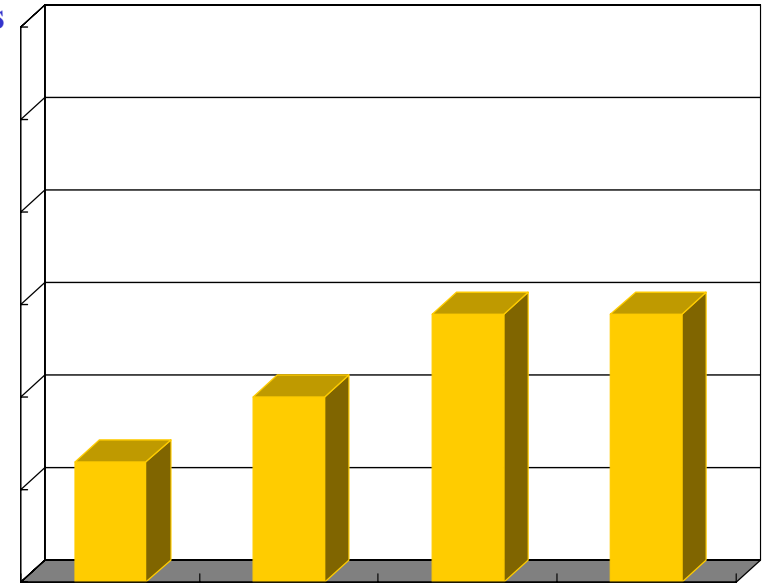
6k cycles



Ball Material Sn-Pb Sn-Ag-Cu Sn-Ag-Cu Sn-Ag-Cu
 Paste Material Sn-Pb Sn-Pb Sn-Ag-Cu Sn-Ag-Bi-Cu

FBGA (16 x 16 mm)

6k cycles



Ball Material Sn-Pb Sn-Ag-Cu Sn-Ag-Cu Sn-Ag-Cu
 Paste Material Sn-Pb Sn-Pb Sn-Ag-Cu Sn-Ag-Bi-Cu

Solder Combination Evaluation(Drop Test)

Sample : Mobile Phone Board (weight : 150g)

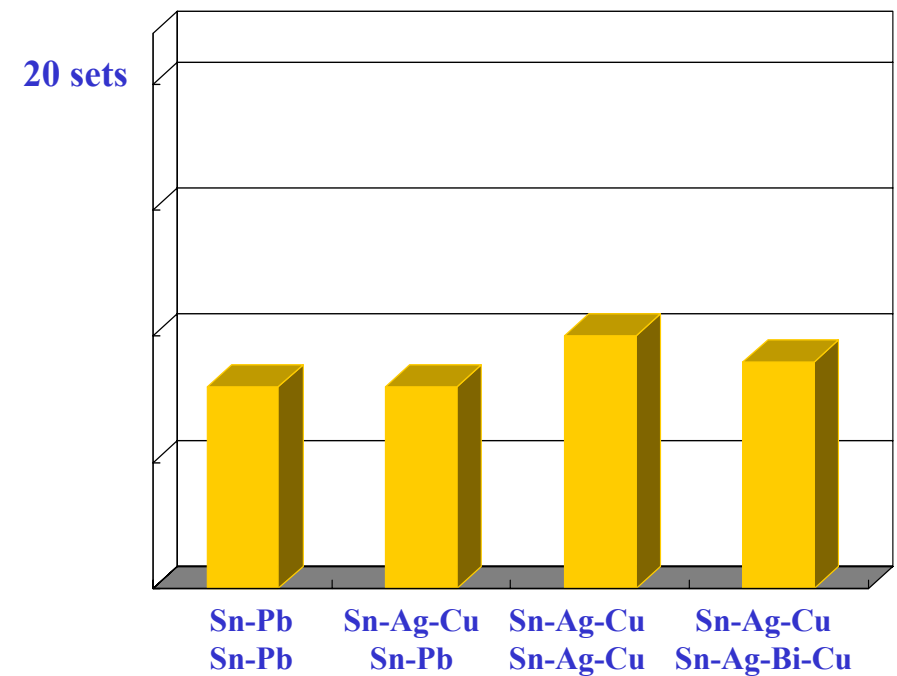
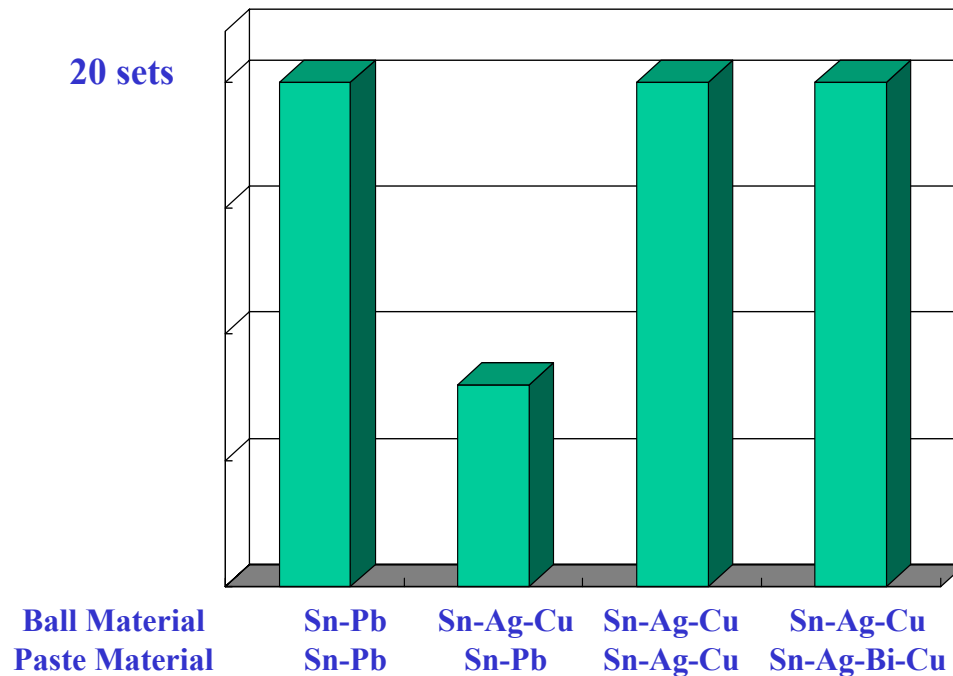
Package : FBGA (6 x 8 mm)/ FBGA (16 x 16 mm)

Condition : 1.5m height, 1set - 6-directions

Non fail set count

FBGA (6 x 8 mm)

FBGA (16 x 16 mm)

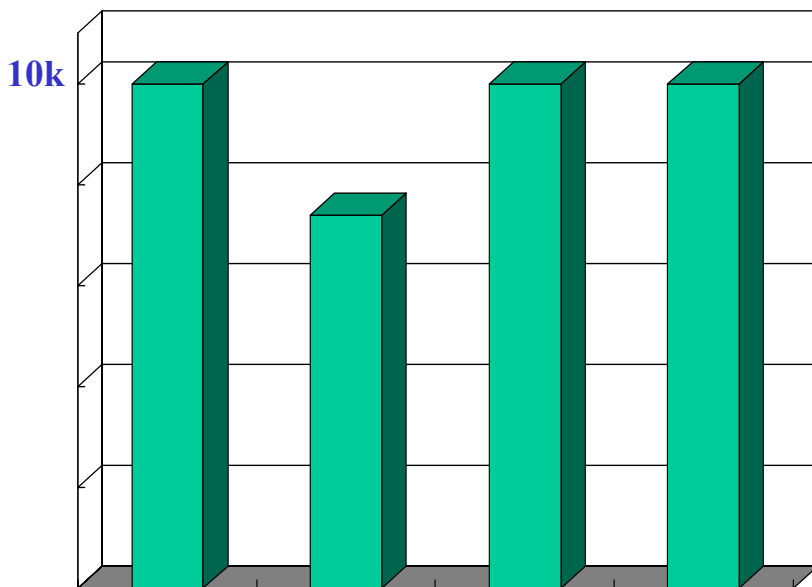


Solder Combination Evaluation (Bending Cycle Test)

Sample : Mobile Phone Board (weight : 150g)
Package : FBGA (6 x 8 mm) / FBGA (16 x 16 mm)
Condition : Span 90 mm, Bend 3.0mm

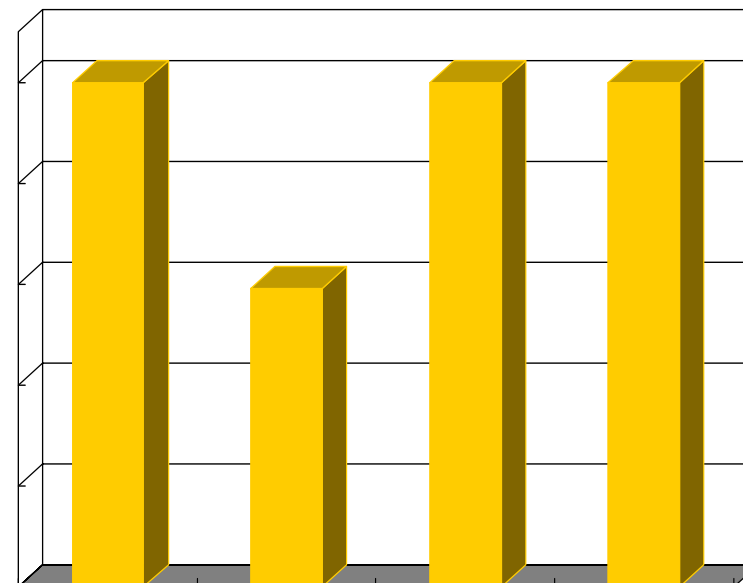
Non fail cycles

FBGA (6 x 8mm)



Ball Material Sn-Pb Sn-Ag-Cu Sn-Ag-Cu Sn-Ag-Cu
 Paste Material Sn-Pb Sn-Pb Sn-Ag-Cu Sn-Ag-Bi-Cu

FBGA (16 x 16 mm)

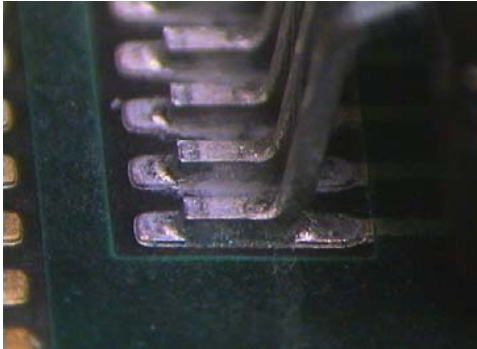


Sn-Pb Sn-Ag-Cu Sn-Ag-Cu Sn-Ag-Cu
 Sn-Pb Sn-Pb Sn-Ag-Cu Sn-Ag-Bi-Cu

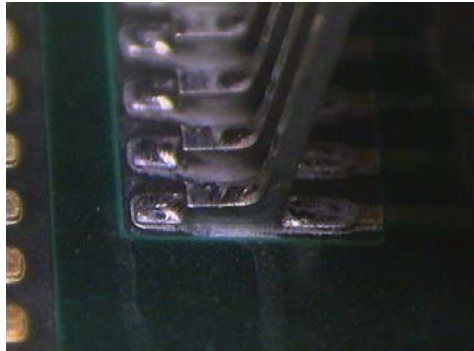
Solder Combination Evaluation(Connection View)

Package : QFP208(0.5mm pitch)

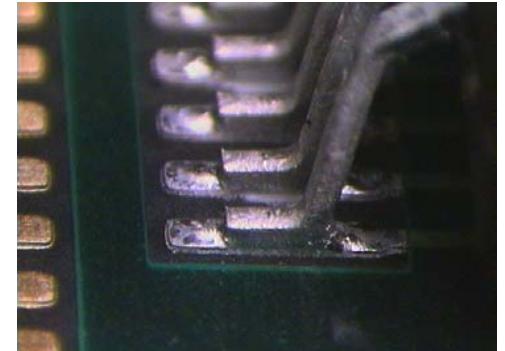
A) Plating : Sn-Pb
Paste : Eutectic Solder
LF : 42-Alloy



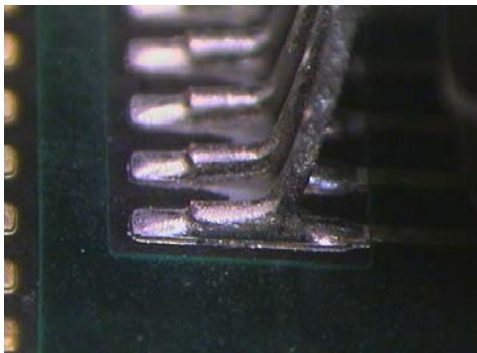
B) Plating : Sn-Pb
Paste : Eutectic Solder
LF : Cu-Alloy



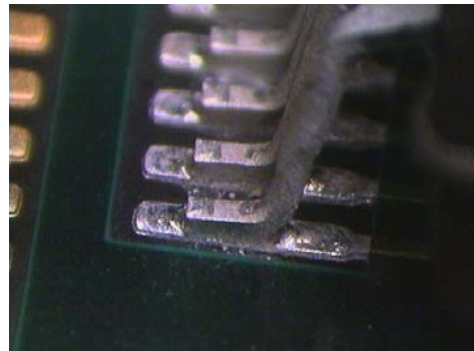
C) Plating : Sn-Bi
Paste : Eutectic Solder
LF : 42-Alloy



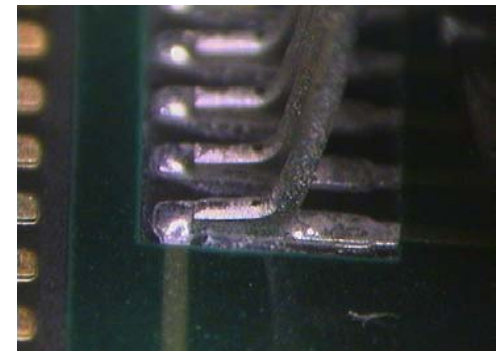
D) Plating : Sn-Bi
Paste : Eutectic Solder
LF : Cu-Alloy



E) Plating : Sn-Bi
Paste : Sn-Ag-Cu
LF : 42-Alloy



F) Plating : Sn-Bi
Paste : Sn-Ag-Cu
LF : Cu-Alloy



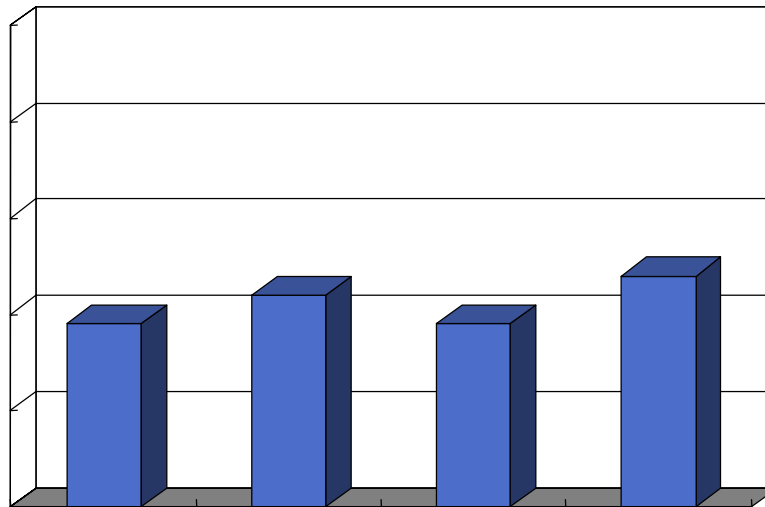
Solder Combination Evaluation(Thermal Cycle)

Board : FR-4,110mm x 110mm x 0.8mmt
 Package : QFP208 (0.5mm pitch)
 TC condition : -25°C ~ RT ~ 125°C

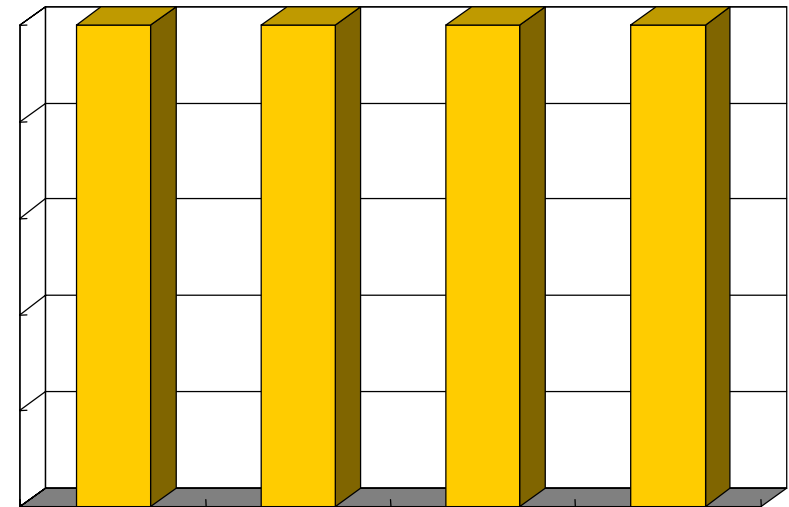
Non fail cycles

5k

42 Alloy



Cu Alloy



Plating Material : Sn-Pb Sn-Pb Sn-Bi Sn-Bi
 Paste Material : Eutectic Sn-Ag-Cu Eutectic Sn-Ag-Cu

Sn-Pb Sn-Pb Sn-Bi Sn-Bi
 Eutectic Sn-Ag-Cu Eutectic Sn-Ag-Cu

Solder Combination Evaluation(Drop Test)

Sample : Box-shaped(Weight : 150g)

Package : A=TSOP-86 B=LQFP-100 C=TQFP-120 D=QFP-208

E=CSOP-48 F=LQFP-120 G=LQFP-256

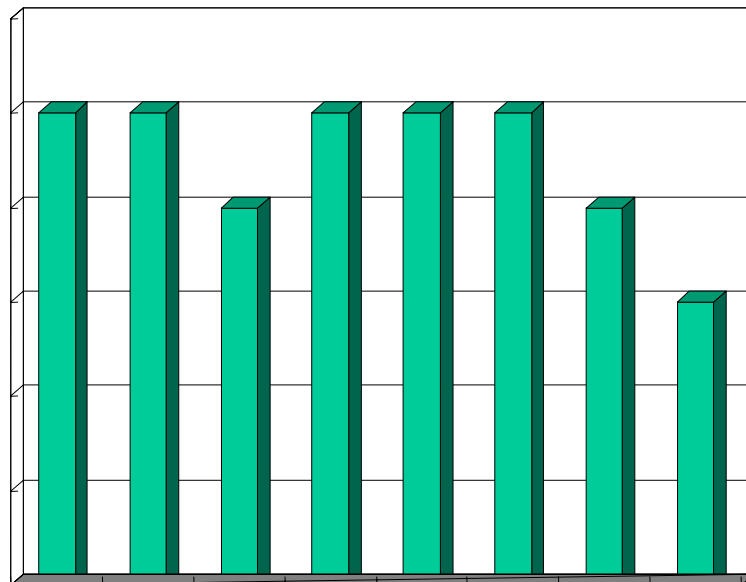
Solder Combination : 1=Sn-Bi plating/Sn-Pb paste 2=Sn-Bi plating/Sn-Bi-Cu paste

Test Condition : Height=1.5m 1set=Landing on 4different surfaces

Non fail set count

Fe-Ni Lead Frame

6-sets



Solder

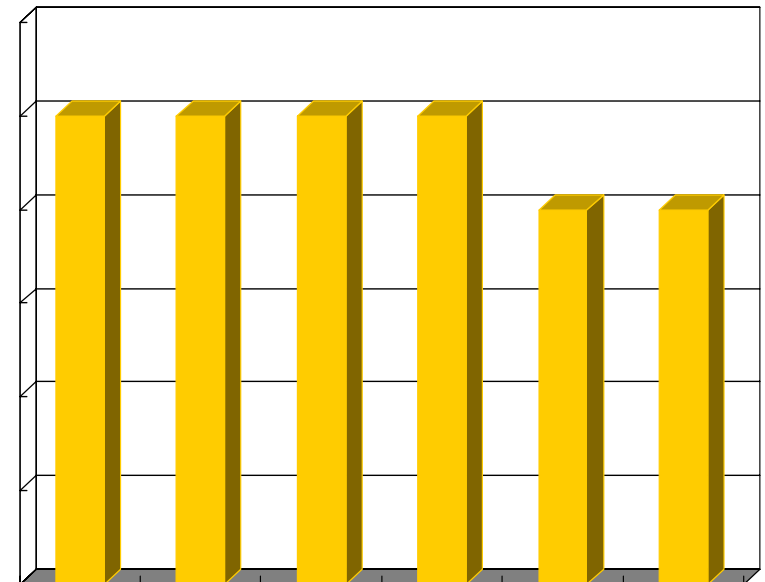
1 2 1 2 1 2 1 2

Package

A B C D

Cu Lead Frame

6-sets



Solder

1 2 1 2 1 2

Package

E F G

Solder Combination Evaluation(Drop Test)

Sample : Box-shaped(Weight : 150g)

Package : A=TSOP-86 B=LQFP-100 C=TQFP-120 D=QFP-208

E=CSOP-48 F=LQFP-120 G=LQFP-256

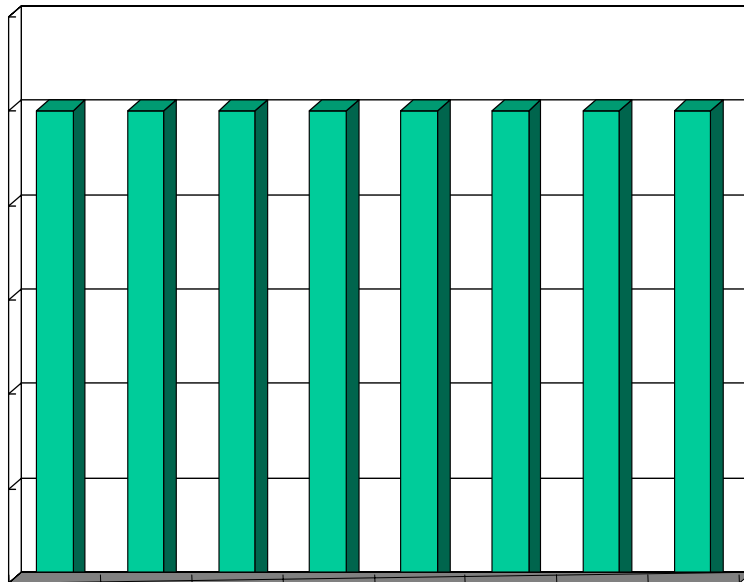
Solder Combination : 1=Sn-Bi plating/Sn-Pb paste 2=Sn-Bi plating/Sn-Bi-Cu paste

Test Condition : 20G,10~2000Hz(1cycle=4minutes) x,y,z girection(1 round)

Non fail rounds

Fe-Ni Lead Frame

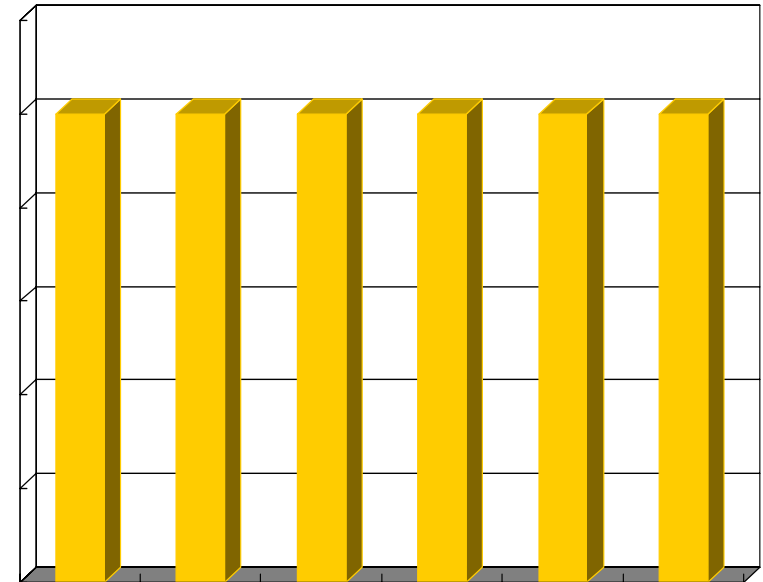
6-rounds



Solder 1 2 1 2 1 2 1 2
Package A B C D

Cu Lead Frame

6-rounds



Solder 1 2 1 2 1 2
Package E F G

Conclusion of Fujitsu Lead-free Package

1. Heat resistivity = 260°C (250°C)x 2 Reflows
2. Terminal materials
 - BGA = Sn-Ag-Cu (Ball)
 - QFP = Sn-Bi (Plating)
3. Discrimination of products by:
 - Parts number, marking, Lead-Free Sticker
4. Solder combinations work just as well with non lead-free version
5. Completed by Dec 2002 (Target)